

April 2001 Revised April 2002

# **FIN1017**

# 3.3V LVDS 1-Bit High Speed Differential Driver

## **General Description**

This single driver is designed for high speed interconnects utilizing Low Voltage Differential Signaling (LVDS) technology. The driver translates LVTTL signal levels to LVDS levels with a typical differential output swing of 350 mV which provides low EMI at ultra low power dissipation even at high frequencies. This device is ideal for high speed transfer of clock or data.

The FIN1017 can be paired with its companion receiver, the FIN1018, or with any other LVDS receiver.

#### **Features**

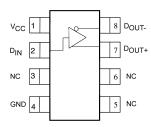
- Greater than 600Mbs data rate
- 3.3V power supply operation
- 0.5ns maximum differential pulse skew
- 1.5ns maximum propagation delay
- Low power dissipation
- Power-Off protection
- Meets or exceeds the TIA/EIA-644 LVDS standard
- Flow-through pinout simplifies PCB layout
- 8-Lead SOIC and US8 packages save space

## **Ordering Code:**

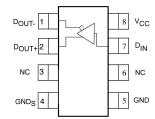
Order Number	Package Number	Package Description
FIN1017M	M08A	8-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow [TUBE]
FIN1017MX	M08A	8-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow [TAPE and REEL]
FIN1017K8X	MAB08A	8-Lead US8, JEDEC MO-187, Variation CA 3.1mm Wide [TAPE and REEL]

# **Connection Diagrams**

#### 8-Lead SOIC



#### Pin Assignment for US-8 Package



Note: Ground pins 4 and 5 for optimum operation.

TOP VIEW

#### **Pin Descriptions**

Pin Name	Description		
D <sub>IN</sub>	LVTTL Data Input		
D <sub>OUT+</sub>	Non-inverting Driver Output		
D <sub>OUT</sub>	Inverting Driver Output		
V <sub>CC</sub>	Power Supply		
GND	Ground		
NC	No Connect		

#### **Function Table**

Input	Outputs			
D <sub>IN</sub>	D <sub>OUT+</sub>	D <sub>OUT</sub>		
L	L	Н		
Н	Н	L		
OPEN	L	Н		

H = HIGH Logic Level L = LOW Logic Level X = Don't Care

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DS500500

# **Absolute Maximum Ratings**(Note 1)

# Recommended Operating Conditions

 $\label{eq:supply Voltage VCC} Supply Voltage (V_{CC}) & -0.5V to +4.6V \\ DC Input Voltage (D_{IN}) & -0.5V to +6V \\ \end{tabular}$ 

Max Junction Temperature (T<sub>J</sub>)

Lead Temperature  $(T_L)$ 

 $\begin{array}{ll} \mbox{(Soldering, 10 seconds)} & 260^{\circ}\mbox{C} \\ \mbox{ESD (Human Body Model)} & \geq 6500\mbox{V} \\ \mbox{ESD (Bus Pins $D_{\mbox{OUT-}}/D_{\mbox{OUT-}}$ to $\mbox{GND})} & \geq 10500\mbox{V} \\ \end{array}$ 

ESD (Machine Model) ≥ 350V

Note 1: The "Absolute Maximum Ratings": are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature and output/input loading variables. Fairchild does not recommend operation of circuits outside databook specification.

#### **DC Electrical Characteristics**

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ (Note 2)	Max	Units
V <sub>OD</sub>	Output Differential Voltage		250	350	450	mV
$\Delta V_{OD}$	V <sub>OD</sub> Magnitude Change from				25	mV
	Differential LOW-to-HIGH	$R_1 = 100 \Omega$ , See Figure 1			20	
Vos	Offset Voltage	11(_ = 100 22, Oce 1 iguie 1	1.125	1.25	1.375	V
ΔV <sub>OS</sub>	Offset Magnitude Change from	]			25	mV
	Differential LOW-to-HIGH					IIIV
I <sub>OFF</sub>	Power-Off Output Current	V <sub>CC</sub> = 0V, V <sub>OUT</sub> = 0V or 3.6V			±20	μΑ
los	Short Circuit Output Current	V <sub>OUT</sub> = 0V			-8	mA
		$V_{OD} = 0V$			±8	i iiiA
V <sub>IH</sub>	Input HIGH Voltage		2.0		V <sub>CC</sub>	V
V <sub>IL</sub>	Input LOW Voltage		GND		0.8	V
I <sub>IN</sub>	Input Current	V <sub>IN</sub> = 0V or V <sub>CC</sub>			±20	μΑ
I <sub>I(OFF)</sub>	Power-Off Input Current	$V_{CC} = 0V, V_{IN} = 0V \text{ or } 3.6V$			±20	μΑ
V <sub>IK</sub>	Input Clamp Voltage	I <sub>IK</sub> = -18 mA	-1.5			V
Icc	Power Supply Current	No Load, V <sub>IN</sub> = 0V or V <sub>CC</sub>			8	mA
		$R_L = 100 \Omega$ , $V_{IN} = 0V$ or $V_{CC}$			10	mA
C <sub>IN</sub>	Input Capacitance			4		pF
C <sub>OUT</sub>	Output Capacitance			6		pF

150°C

Note 2: All typical values are at  $T_A = 25^{\circ}C$  and with  $V_{CC} = 3.3V$ .

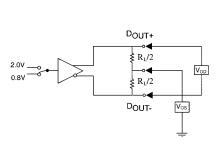
#### **AC Electrical Characteristics**

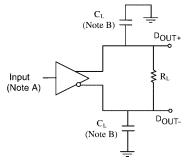
Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ (Note 3)	Max	Units
t <sub>PLHD</sub>	Differential Propagation Delay		0.5		1.5	ns
	LOW-to-HIGH		0.5		1.5	113
t <sub>PHLD</sub> Differential Propagation Delay HIGH-to-LOW	Differential Propagation Delay	$R_L = 100 \ \Omega, \ C_L = 10 pF,$	0.5		1.5	ns
	HIGH-to-LOW					
t <sub>TLHD</sub>	Differential Output Rise Time (20% to 80%)	See Figure 2 and Figure 3	0.4		1.0	ns
t <sub>THLD</sub>	Differential Output Fall Time (80% to 20%)		0.4		1.0	ns
t <sub>SK(P)</sub>	Pulse Skew  t <sub>PLH</sub> - t <sub>PHL</sub>				0.5	ns
t <sub>SK(PP)</sub>	Part-to-Part Skew (Note 4)				1.0	ns

Note 3: All typical values are at  $T_A = 25$ °C and with  $V_{CC} = 3.3$ V.

Note 4: t<sub>SK(PP)</sub> is the magnitude of the difference in propagation delay times between any specified terminals of two devices switching in the same direction (either LOW-to-HIGH or HIGH-to-LOW) when both devices operate with the same supply voltage, same temperature, and have identical test circuits.





 $\label{eq:Note A: All input pulses have frequency = 10 MHz, $t_R$ or $t_F = 2$ ns} \\ \mbox{Note B: $C_L$ includes all probe and fixture capacitances}$ 

FIGURE 1. Differential Driver DC Test Circuit

FIGURE 2. Differential Driver Propagation Delay and Transition Time Test Circuit

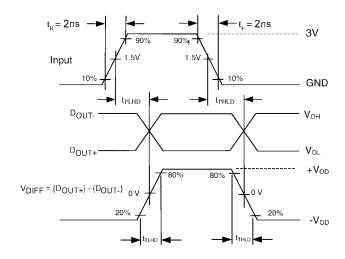
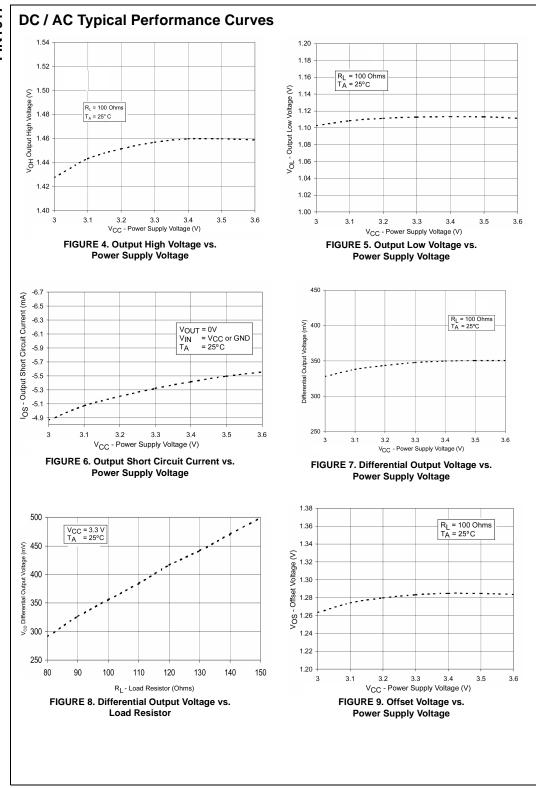
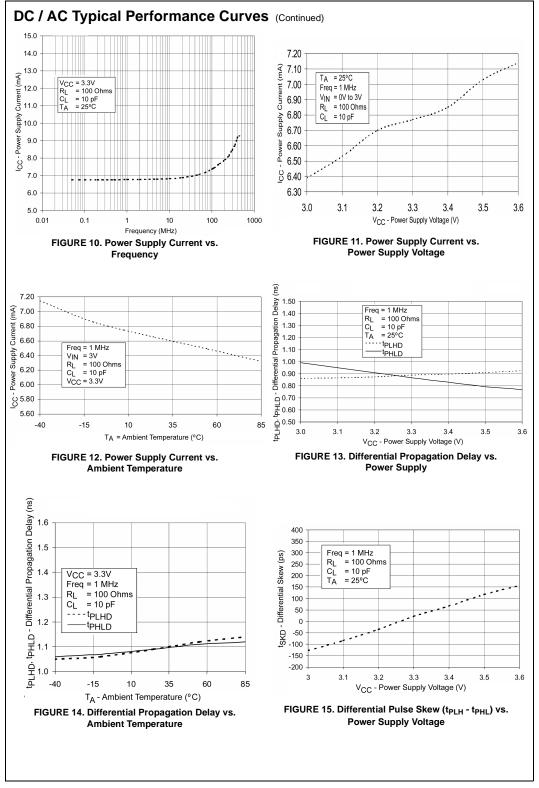


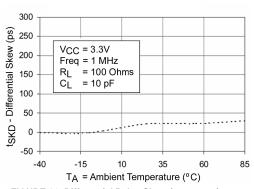
FIGURE 3. AC Waveforms

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# DC / AC Typical Performance Curves (Continued)

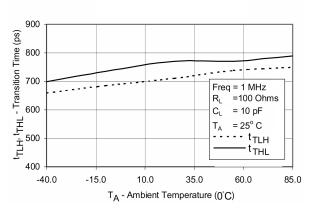


=100 Ohms 1100 1050 tTHL - Transition Time (ps) = 10 pF 1000 = 25° C 950 --- t<sub>TLH</sub> 900 850 800 750 700 650 600 550 ŤĤ 500 450 400 3.0 3.1 3.2 3.3 3.4 3.5 3.6  $V_{CC}$  - Pow er Supply Voltage (V)

Freq = 1 MHz

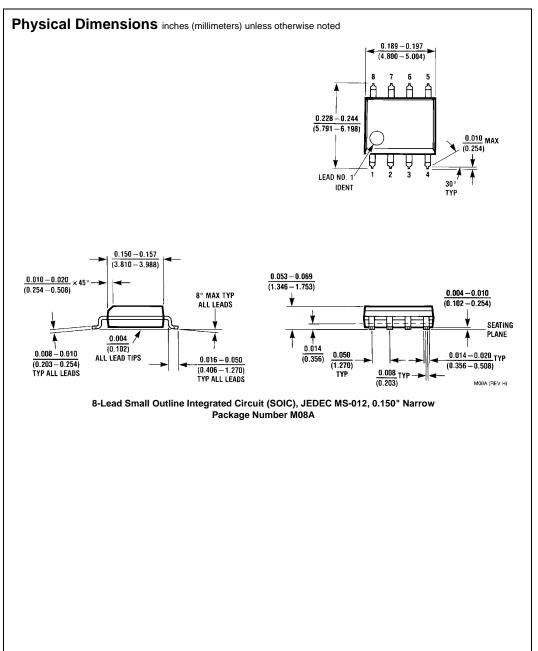
FIGURE 16. Differential Pulse Skew ( $t_{PLH}$  -  $t_{PHL}$ ) vs. **Ambient Temperature** 

FIGURE 17. Transition Time vs. **Power Supply Voltage** 

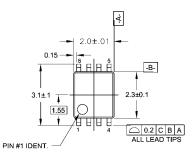


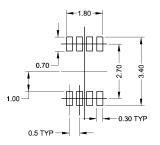
1200 1150

FIGURE 18. Transition Time vs. **Ambient Temperature** 

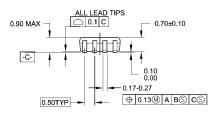


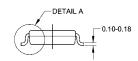
## Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

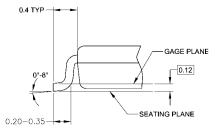




LAND PATTERN RECOMMENDATION







NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-187
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

DETAIL A

MAB08AREVC

8-Lead US8, JEDEC MO-187, Variation CA 3.1mm Wide Package Number MAB08A

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